Search Notes

Application/Control	No.

10/767,763

OGAWA, HIDEHIKO

Applicant(s)/Patent under Reexamination

Examiner

Art Unit

Thomas D. Lee

2625

SEARCHED				
Class	Subclass	Date	Examiner	
358	1.15, 402, 440	2/22/2007	TDL	
379	100.01	2/22/2007	TDL	
379	100.08	2/22/2007	TDL	
379	100.13	2/22/2007	TDL	
379	100.17	2/22/2007	TDL	
updated		7/19/2007	TDL	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
A-18/19 170 770			
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